Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/810,692	KOJIMA ET AL.	
Examiner	Art Unit	
Tae H. Yoon	1714	

SEARCHED					
Class	Subclass	Date	Examiner		
523	115	10-16-0b	2		
	116				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Inventor Scara	10/14/00	1 1/2		